

AUTOMOTIVE GRADE

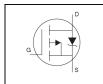
AUIRFR5505 AUIRFU5505

Features

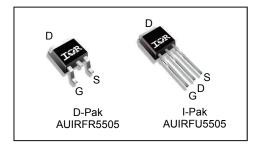
- Advanced Planar Technology
- Low On-Resistance
- P-Channel
- · Dynamic dv/dt Rating
- 150°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Repetitive Avalanche Allowed up to Tjmax
- · Lead-Free, RoHS Compliant
- Automotive Qualified *

Description

Specifically designed for Automotive applications, this Cellular design of HEXFET® Power MOSFETs utilizes the latest processing techniques to achieve low on-resistance per silicon area. This benefit combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in Automotive and a wide variety of other applications.



V _{DSS}		-55V
R _{DS(on)}	max.	0.11Ω
I _D		-18 A



G	D	S
Gate	Drain	Source

Boss nort number	Dookogo Typo	Standard Pack		Ordershie Bort Number
Base part number	Package Type	Form	Quantity	Orderable Part Number
AUIRFU5505	I-Pak	Tube	75	AUIRFU5505
ALUDEDEEDE	D. Dok	Tube	75	AUIRFR5505
AUIRFROOUS	AUIRFR5505 D-Pak		3000	AUIRFR5505TRL

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ -10V	-18	
I _D @ T _C = 100°C			Α
I _{DM}	Pulsed Drain Current ①	-64	
P _D @T _C = 25°C	Maximum Power Dissipation	57	W
	Linear Derating Factor	0.45	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
Single Pulse Avalanche Energy (Thermally Limited) ②		150	mJ
Avalanche Current ①		-9.6	Α
E _{AR}	Repetitive Avalanche Energy ①	5.7	mJ
dv/dt	Peak Diode Recovery dv/dt3	-5.0	V/ns
TJ	Operating Junction and	-55 to + 150	
T_{STG}	Storage Temperature Range		°C
_	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{ heta JC}$	Junction-to-Case		2.2	
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount) ∅		50	°C/W
$R_{\theta JA}$	Junction-to-Ambient		110	

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^{*}Qualification standards can be found at www.infineon.com



Static @ $T_J = 25$ °C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	-55			V	$V_{GS} = 0V, I_{D} = -250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		-0.049		V/°C	Reference to 25°C, I _D = -1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance			0.11	Ω	$V_{GS} = -10V, I_D = -9.6A \oplus$
$V_{GS(th)}$	Gate Threshold Voltage	-2.0		-4.0	V	$V_{DS} = V_{GS}$, $I_D = -250\mu A$
gfs	Forward Trans conductance	4.2			S	$V_{DS} = -25V, I_{D} = -9.6A$ ©
ı	Drain-to-Source Leakage Current			-25		$V_{DS} = -55 \text{ V}, V_{GS} = 0 \text{ V}$
I _{DSS}	Drain-to-Source Leakage Current			-250	μA	$V_{DS} = -44V, V_{GS} = 0V, T_{J} = 150^{\circ}C$
	Gate-to-Source Forward Leakage			-100	- Δ	$V_{GS} = -20V$
I _{GSS}	Gate-to-Source Reverse Leakage			100	nA	$V_{GS} = 20V$

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Q_g	Total Gate Charge	 	32		$I_{D} = -9.6A$
Q_{gs}	Gate-to-Source Charge	 	7.1	nC	$V_{DS} = -44V$
Q_{gd}	Gate-to-Drain Charge	 	15		V _{GS} = -10V, See Fig 6 and 13 ④
t _{d(on)}	Turn-On Delay Time	 12			$V_{DD} = -28V$
t _r	Rise Time	 28		no	$I_{D} = -9.6A$
$t_{d(off)}$	Turn-Off Delay Time	 20		ns	$R_G = 2.6\Omega$
t _f	Fall Time	 16			$R_D = 2.8\Omega$, See Fig 10 @
L _D	Internal Drain Inductance	 4.5			Between lead, 6mm (0.25in.)
L _S	Internal Source Inductance	 7.5			from package \$ 4 and center of die contact
C _{iss}	Input Capacitance	650			$V_{GS} = 0V$
Coss	Output Capacitance	 270		pF	$V_{DS} = -25V$
C_{rss}	Reverse Transfer Capacitance	 120			f = 1.0MHz, See Fig. 5

Diode Characteristics

<u> </u>						
	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current (Body Diode)			-18		MOSFET symbol showing the
					- /\	integral reverse
I _{SM}	Pulsed Source Current (Body Diode) ①			-64		p-n junction diode.
V_{SD}	Diode Forward Voltage			-1.6	V	$T_J = 25^{\circ}C, I_S = -9.6A, V_{GS} = 0V $ @
t _{rr}	Reverse Recovery Time		51	77	ns	$T_J = 25^{\circ}C$, $I_F = -9.6A$
Q_{rr}	Reverse Recovery Charge		110	160	nC	di/dt = 100A/µs ④
t _{on}	Forward Turn-On Time	Intrinsio	turn-or	time is	negligil	ble (turn-on is dominated by LS+LD)

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- $^{\circ}$ V_{DD} = -25V, starting T_J = 25°C, L = 2.8mH, R_G = 25 Ω , I_{AS} = -6.6A. (See Fig.12)
- $\label{eq:loss_space} \begin{tabular}{ll} \$
- 4 Pulse width $\leq 300 \mu s$; duty cycle $\leq 2\%$.
- ⑤ This is applied for I-PAK, L_S of D-PAK is measured between lead and center of die contact .
- © Uses IRF9Z24N data and test conditions.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994



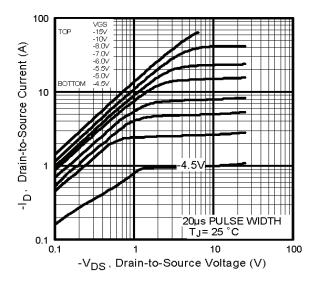


Fig. 1 Typical Output Characteristics

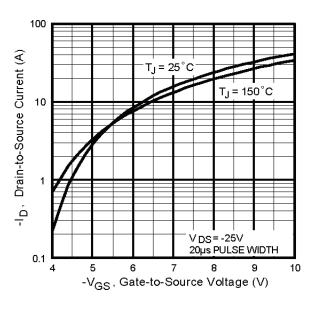


Fig. 3 Typical Transfer Characteristics

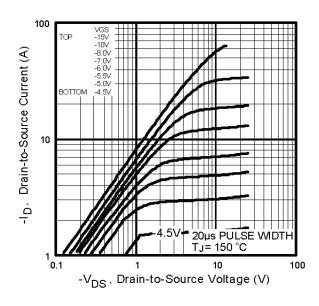


Fig. 2 Typical Output Characteristics

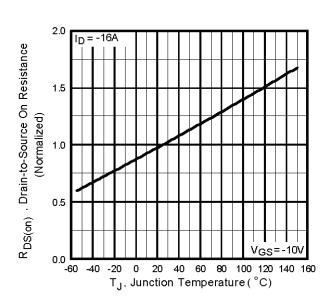


Fig. 4 Normalized On-Resistance vs. Temperature



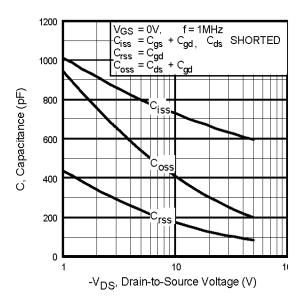


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

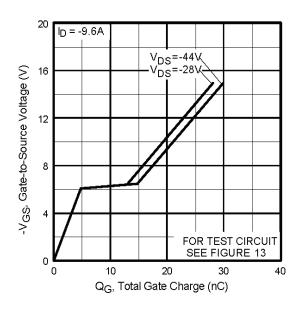


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

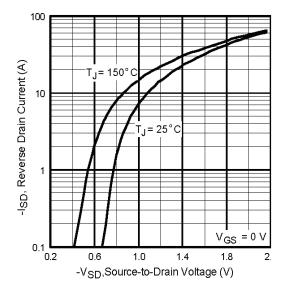


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

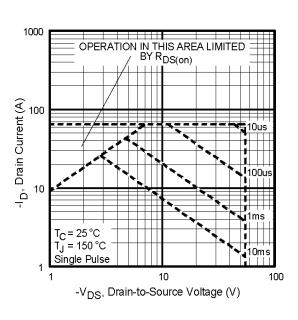


Fig 8. Maximum Safe Operating Area



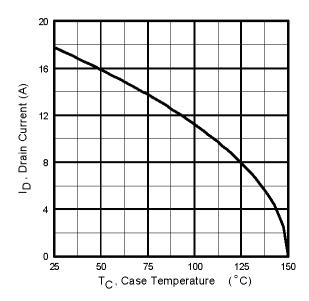


Fig 9. Maximum Drain Current vs. Case Temperature

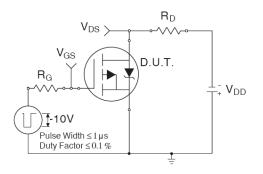


Fig 10a. Switching Time Test Circuit

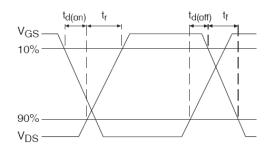


Fig 10b. Switching Time Waveforms

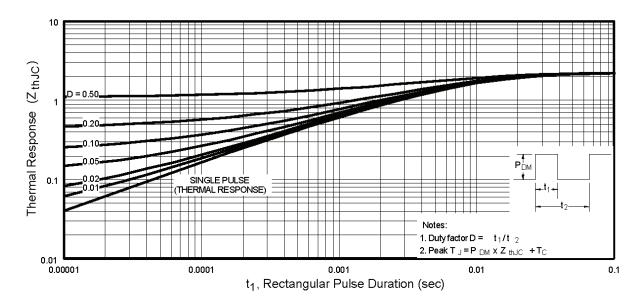


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



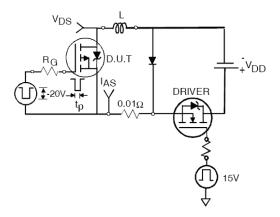


Fig 12a. Unclamped Inductive Test Circuit

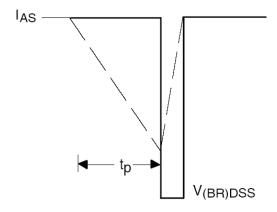


Fig 12b. Unclamped Inductive Waveforms

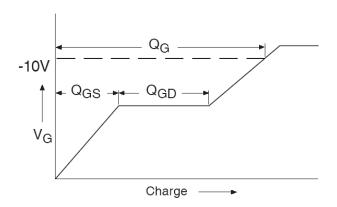


Fig 13a. Gate Charge Waveform

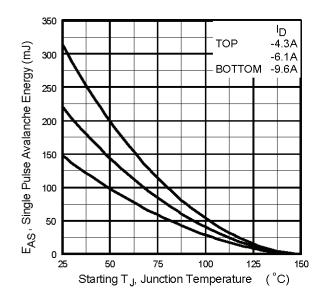


Fig 12c. Maximum Avalanche Energy vs. Drain Current

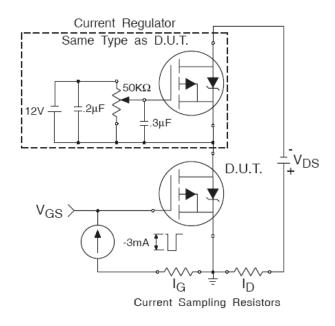
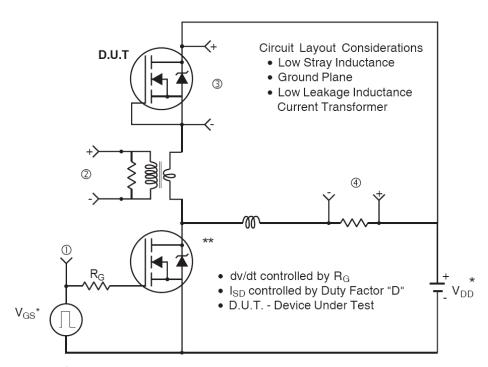


Fig 13b. Gate Charge Test Circuit

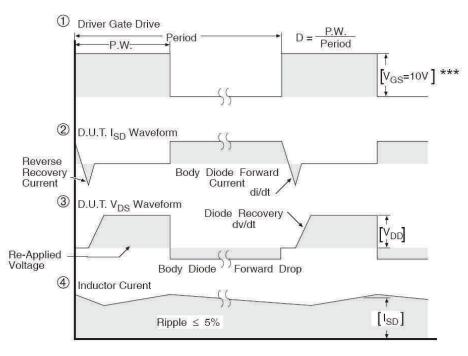


Peak Diode Recovery dv/dt Test Circuit



^{*} Reverse Polarity for P-Channel

^{**} Use P-Channel Driver for P-Channel Measurements



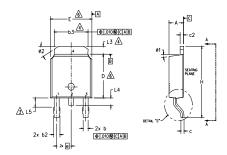
*** V_{GS} = 5.0V for Logic Level and 3V Drive Devices

Fig 14. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

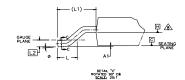
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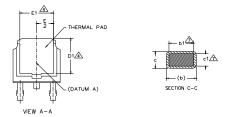


D-Pak (TO-252AA) Package Outline (Dimensions are shown in millimeters (inches))









NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- LEAD DIMENSION UNCONTROLLED IN L5.
- A- DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- 5.— SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- Limension D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- A- DIMENSION 61 & c1 APPLIED TO BASE METAL ONLY.
- ♠ DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 9.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-252AA.

S Y M		DIMENSIONS					
B O	MILLIM	ETERS	INC	HES	O T		
O L	MIN.	MAX.	MIN.	MAX.	E S		
Α	2.18	2.39	.086	.094			
A1	-	0.13	-	.005			
b	0.64	0.89	.025	.035			
ь1	0.65	0.79	.025	.031	7		
b2	0.76	1.14	.030	.045			
b3	4.95	5.46	.195	.215	4		
С	0.46	0.61	.018	.024			
c1	0.41	0.56	.016	.022	7		
c2	0.46	0.89	.018	.035			
D	5.97	6.22	.235	.245	6		
D1	5.21	-	.205	-	4		
Ε	6.35	6.73	.250	.265	6		
E1	4.32	-	.170	-	4		
е	2.29	BSC	.090	BSC			
Н	9.40	10.41	.370	.410			
L	1.40	1.78	.055	.070			
L1	2.74	BSC	.108	REF.			
L2	0.51	BSC	.020	BSC			
L3	0.89	1.27	.035	.050	4		
L4	-	1.02	-	.040			
L5	1.14	1.52	.045	.060	3		
ø	0,	10*	0,	10°			
ø1	0,	15*	0,	15*			
ø2	25*	35°	25*	35*			

LEAD ASSIGNMENTS

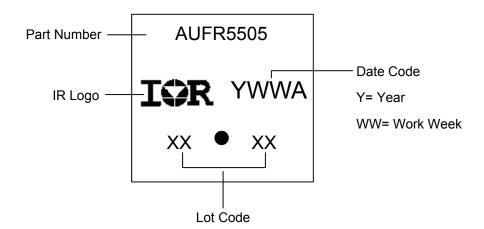
HEXFET

- 1.- GATE
- 2.- DRAIN
- 3.- SOURCE 4.- DRAIN

IGBT & CoPAK

- 1.- GATE
- 2.- COLLECTOR
- 3.- EMITTER 4.- COLLECTOR

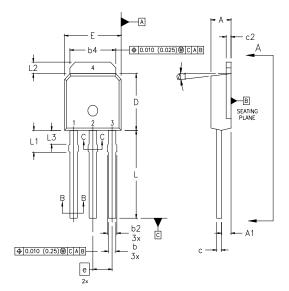
D-Pak (TO-252AA) Part Marking Information

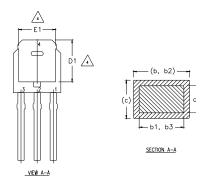


Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



I-Pak (TO-251AA) Package Outline (Dimensions are shown in millimeters (inches)





NOTES:

SYMBOL

A1

b

ь1

b2

b4

c1 c2

D

D1

E1

e L

L1

L2

L3

- 1 DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994.
- 2 DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3 DIMENSION D & E DO NOT INCLUDE MOLD FLASH, MOLD FLASH SHALL NOT EXCEED 0.005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 4 THERMAL PAD CONTOUR OPTION WITHIN DIMENSION 64, L2, E1 & D1.

INCHES

.094

0.045

0.035

0.031

0.045

0.041

0.215

0.024

0.022

0.035

0.245

0.265

0.380

0.090

0.050

0.060

15*

0.086

0.035

0.025

0.025

0.030

0.030

0.195

0.018

0.016

0.018

0.235

0.205

0.250

0.170

0.350

0.075

0.035

0.045

0.090 BSC

NOTES

LEAD DIMENSION UNCONTROLLED IN L3.

2.39

1.14

0.89

0.79

1.14

1.04

5.46

0.61

0.56

0.86

6.22

6.73

9.60

2.29

1.27

1.52

- 6 DIMENSION 61, 63 APPLY TO BASE METAL ONLY.
- OUTLINE CONFORMS TO JEDEC OUTLINE TO-251AA.

DIMENSIONS

8 CONTROLLING DIMENSION : INCHES.

MILLIMETERS

MIN.

2.18

0.89

0.64

0.64

0.76

0.76

5.00

0.46

0.41

.046

5.97

5.21

6.35

4.32

8.89

1,91

0.89

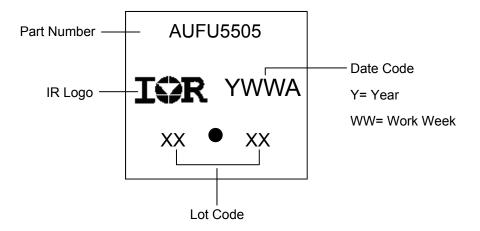
1.14

LEAD	ASSIGNMENTS
------	--------------------

. 1

- 1.- GATE
- 2.- DRAIN 3.- SOURCE
- 4.- DRAIN

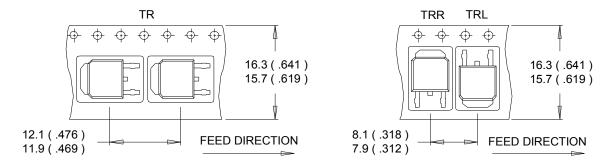
I-Pak (TO-251AA) Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

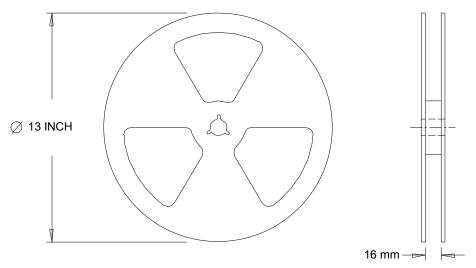


D-Pak (TO-252AA) Tape & Reel Information (Dimensions are shown in millimeters (inches))



NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES:

1. OUTLINE CONFORMS TO EIA-481.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information

			Automotive				
Ir		(per AEC-Q101)					
			is part number(s) passed Automotive qualification. Infineon's consumer qualification level is granted by extension of the higher el.				
Moisture Sensitivity Level		D-Pak	MCI 4				
		I-Pak	MSL1				
			Class M3 (+/- 250V) [†]				
	Machine Model	AEC-Q101-002					
50 5	Harris Dada Madal	Class H1B (+/- 800V) [†]					
ESD	Human Body Model	AEC-Q101-001					
Charged Device Model		Class C5 (+/- 2000V) [†]					
		AEC-Q101-005					
RoHS Compliant Yes		Yes					

[†] Highest passing voltage.

Revision History

Date	Comments
10/12/2015	Updated datasheet with corporate template
	Corrected ordering table on page 1.

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